



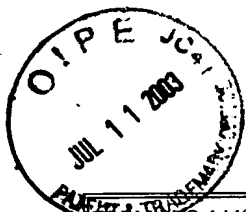
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Sheet 1 of 1

FORM PTO-1449 (Modified) (Rev. 7-80)		U.S. Dept. of Commerce Patent and Trademark Office		Atty Docket No. VTEK-110		Appln. No. 09/698,693	
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)				Applicant Jose Gabriel Menchero			
				Filing Date October 27, 2000		Group Unknown	
U.S. PATENT DOCUMENTS							
*Examiner Initials		Document Number	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
FOREIGN PATENT DOCUMENTS							
*Examiner Initials		Document Number	Date	Country	Class	Subclass	Translation YES NO
	AC						
OTHER DOCUMENTS							
<i>m</i>	AD	Carino, David, "Combining Attribution Effects Over Time," <u>The Journal of Performance Measurement</u> , Summer 1999, pages 5-14.					
Examiner <i>Ngan Nguyen</i>				Date Considered <i>3/18/04</i>			
* Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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U.S. PATENT DOCUMENTS							
*Examiner Initials	Document Number	Date	Name	Class	Subclass	Filing Date	
<i>qm</i>	AB	5,761,442	06/02/1998	Barr et al.	395	236	08/31/1994
<i>mm</i>	AC	5,930,762	07/27/1999	Masch	705	7	09/24/1996
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<i>mm</i>	AH						
<i>mm</i>	AI						
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	AM						
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FOREIGN PATENT DOCUMENTS

*Examiner Initials		Document Number	Date	Country	Class	Subclass	Translation YES NO
	AF						
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OTHER DOCUMENTS

<i>mm</i>	AH	Menchero, Jose G., "A Fully Geometric Approach to Performance Attribution," <u>The Journal of Performance Measurement</u> , Winter 2000/2001, pages 22-30.					
<i>mm</i>	AI	Menchero, Jose G., "An Optimized Approach to Linking Attribution Effects Over Time," <u>The Journal of Performance Measurement</u> , Fall 2000, pages 36-42.					
	AJ						
	AK						
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Examiner

Ngan Nguyen

Date Considered

3/18/04

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